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Vishay Siliconix

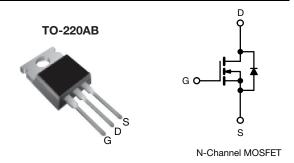
RoHS

COMPLIANT HALOGEN

FREE

EF Series Power MOSFET with Fast Body Diode

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	650				
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V	0.098			
Q _g (Max.) (nC)	155				
Q _{gs} (nC)	22				
Q _{gd} (nC)	43				
Configuration	Single				



FEATURES

- Fast body diode MOSFET using E series technology
- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Low figure-of-merit (FOM): Ron x Qg
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity discharge (HID)
 - Light emitting diodes (LEDs)
- Consumer and computing
 - ATX power supplies
- Industrial
 - Welding
 - Battery chargers
- Renewable energy
 - Solar (PV inverters)
- Switch mode power suppliers (SMPS)
- Applications using the following topologies
 - LLC
 - Phase shifted bridge (ZVS)
 - 3-level inverter
 - AC/DC bridge

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free and Halogen-free	SiHP33N60EF-GE3			

ABSOLUTE MAXIMUM RATINGS (T_C						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	600	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Prais Current (T = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		33	А	
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 100 °C	I _D	21		
Pulsed Drain Current (Typical) a			I _{DM}	100		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	691	mJ	
Maximum Power Dissipation			P _D	278	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		-1V / / -11	70	1//20	
Reverse Diode dV/dt d			dV/dt	50	- V/ns	
Soldering Recommendations (Peak Temperature) c	ommendations (Peak Temperature) c for 10 s			300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_q = 25 Ω , I_{AS} = 7 A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dl/dt = 900 A/ μ s, starting T_J = 25 °C.



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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W		
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.45]		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		•				Į.	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D = 250 μA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.72	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Octo Corres Laslana	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Gate-Source Leakage			V _{GS} = ± 30 V		-	± 1	μΑ
Zeve Cata Valtage Divis Comment		V _{DS} =	= 480 V, V _{GS} = 0 V	-	-	1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 480 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 16.5 A	-	0.085	0.098	Ω
Forward Transconductance a	9 _{fs}	V _{DS} =	= 30 V, I _D = 16.5 A	-	12	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	3454	-	
Output Capacitance	C _{oss}		$V_{DS} = 100 V,$	-	154	-	
Reverse Transfer Capacitance	C _{rss}		f = 1 MHz		8	-	pF
Effective Output Capacitance, Energy Related ^b	C _{o(er)}	V 0.V.V 0.VV 400.V		-	121	-	
Effective Output Capacitance, Time Related c	C _{o(tr)}	$V_{GS} = 0$	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V to } 480 \text{ V}$		437	-	
Total Gate Charge	Qg			-	103	155	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 16.5 \text{ A}, V_{DS} = 480 \text{ V}$	-	22	-	nC
Gate-Drain Charge	Q _{gd}			-	43	-	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 480 V, I _D = 16.5 A		-	28	56	
Rise Time	t _r			-	43	86	ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 1$	$R_g = 9.1 \Omega, V_{GS} = 10 V$		161	242	
Fall Time	t _f			-	48	96	1
Gate Input Resistance	R_g	f = 1	f = 1 MHz, open drain		0.5	1.0	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET sym	MOSFET symbol showing the		-	33	
Pulsed Diode Forward Current	I _{SM}	integral reverse p - n junction diode		-	100	-	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 16.5 A, V _{GS} = 0 V		-	0.9	1.2	V
Reverse Recovery Time	t _{rr}			-	162	324	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25$ °C, $I_F = I_S = 16.5$ A, $I_R = 100$ A/ $I_R = 100$ V		-	1.0	2.0	μC
Reverse Recovery Current	I _{RRM}			_	13	_	A

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} . c. $C_{oss(tr)}$ is a fixed capacitance that gives the charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

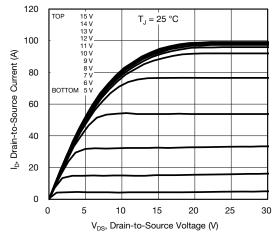


Fig. 1 - Typical Output Characteristics

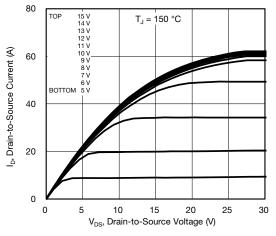


Fig. 2 - Typical Output Characteristics

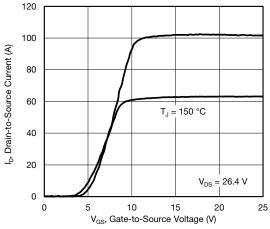


Fig. 3 - Typical Transfer Characteristics

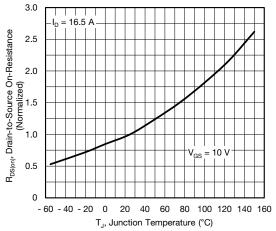


Fig. 4 - Normalized On-Resistance vs. Temperature

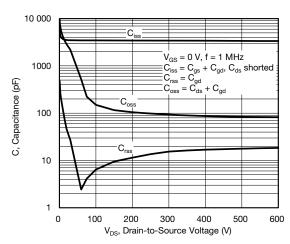


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

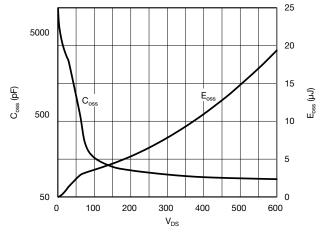


Fig. 6 - Coss and Eoss vs. VDS



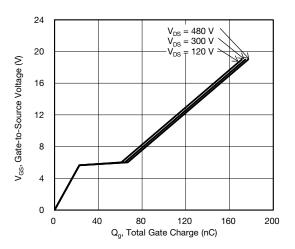


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

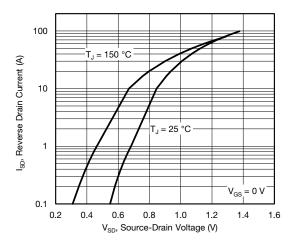


Fig. 8 - Typical Source-Drain Diode Forward Voltage

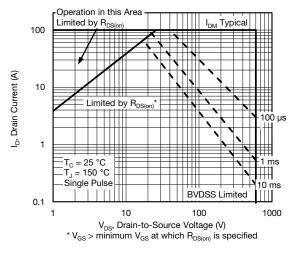


Fig. 9 - Maximum Safe Operating Area

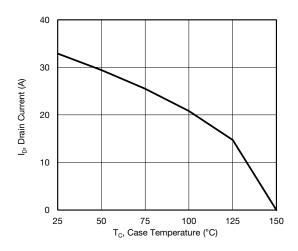


Fig. 10 - Maximum Drain Current vs. Case Temperature

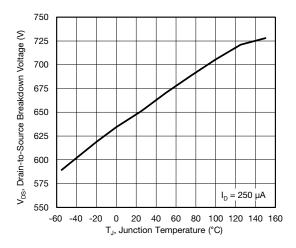


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature



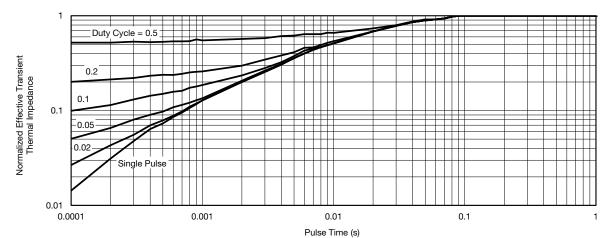


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

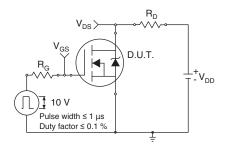


Fig. 13 - Switching Time Test Circuit

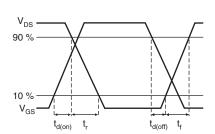


Fig. 14 - Switching Time Waveforms

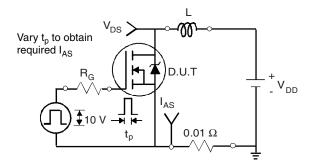


Fig. 15 - Unclamped Inductive Test Circuit

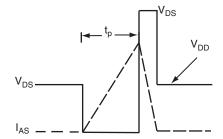


Fig. 16 - Unclamped Inductive Waveforms

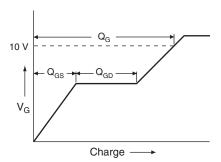


Fig. 17 - Basic Gate Charge Waveform

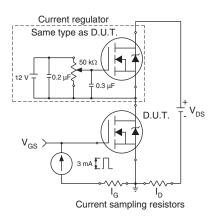
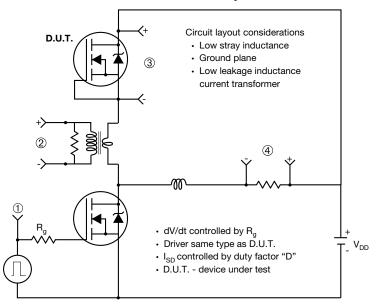


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



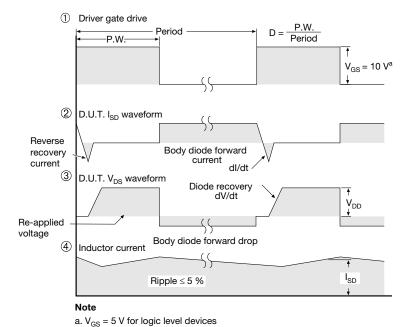
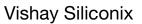


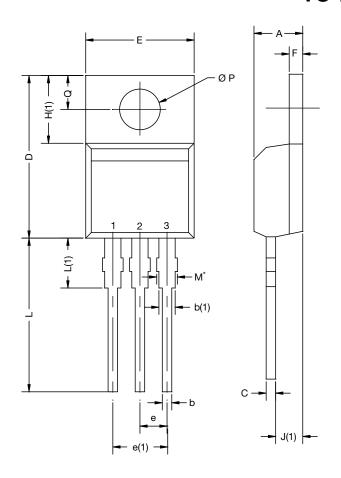
Fig. 19 - For N-Channel

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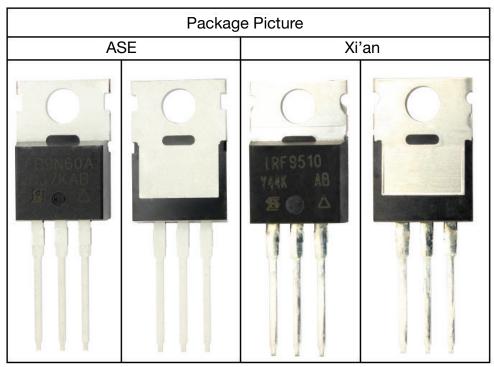
TO-220-1



DIM.	MILLIM	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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